Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/626,634	CHENG ET AL.	
Examiner	Art Unit	
Naum B. Levin	2825	

SEARCHED					
Class	Subclass	Date	Examiner		
716	4-6	12/2/2005	N L		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
12/02/5, see	xt search - interference printout	12/2/2005	NL		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT)- See search histoty printouts	12/2/2005	ΝL
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